

PRODUCT FEATURES

- IGBT CHIP(Trench+Field Stop technology)
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Low switching losses



APPLICATIONS

- High frequency switching application
- Medical applications
- Motion/servo control
- UPS systems

ABSOLUTE MAXIMUM RATINGS-IGBT ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
V_{CES}	Collector Emitter Voltage	$T_J=25^\circ\text{C}$	1200	V
V_{GES}	Gate Emitter Voltage		± 20	
I_C	DC Collector Current	$T_C=25^\circ\text{C}, T_{Jmax}=175^\circ\text{C}$	422	A
		$T_C=95^\circ\text{C}, T_{Jmax}=175^\circ\text{C}$	300	
I_{CM}	Repetitive Peak Collector Current	$tp=1\text{ms}$	600	
P_{tot}	Power Dissipation Per IGBT	$T_C=25^\circ\text{C}, T_{Jmax}=175^\circ\text{C}$	1428	W

ABSOLUTE MAXIMUM RATINGS-Diode ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
V_{RRM}	Repetitive Reverse Voltage	$T_J=25^\circ\text{C}$	1200	V
$I_{F(AV)}$	Average Forward Current		300	A
I_{FRM}	Repetitive Peak Forward Current	$tp=1\text{ms}$	600	
I^2t		$T_J=125^\circ\text{C}, t=10\text{ms}, V_R=0\text{V}$	18000	A^2s

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MMG300D120UA6TC

ELECTRICAL CHARACTERISTICS-IGBT ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit	
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=12\text{mA}$	5.0	5.8	6.5	V	
$V_{CE(sat)}$	Collector - Emitter Saturation Voltage	$I_C=300\text{A}, V_{GE}=15\text{V}, T_J=25^{\circ}\text{C}$		1.85	2.35		
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_J=125^{\circ}\text{C}$		2.15			
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_J=150^{\circ}\text{C}$		2.2			
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=25^{\circ}\text{C}$			1	mA	
		$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=150^{\circ}\text{C}$			10		
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 20\text{V}, T_J=25^{\circ}\text{C}$	-400		400	nA	
R_{Gint}	Integrated Gate Resistor			1.8		Ω	
Q_g	Gate Charge	$V_{CE}=600\text{V}, I_C=300\text{A}, V_{GE}=15\text{V}$		1.5		μC	
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		21		nF	
C_{res}	Reverse Transfer Capacitance				1		nF
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=600\text{V}, I_C=300\text{A}$ $R_G=2.7\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=25^{\circ}\text{C}$	110		ns	
			$T_J=125^{\circ}\text{C}$	120		ns	
			$T_J=150^{\circ}\text{C}$	130		ns	
t_r	Rise Time		$T_J=25^{\circ}\text{C}$	70		ns	
			$T_J=125^{\circ}\text{C}$	75		ns	
			$T_J=150^{\circ}\text{C}$	80		ns	
$t_{d(off)}$	Turn off Delay Time	$T_J=25^{\circ}\text{C}$	440		ns		
		$T_J=125^{\circ}\text{C}$	480		ns		
		$T_J=150^{\circ}\text{C}$	500		ns		
t_f	Fall Time	$T_J=25^{\circ}\text{C}$	80		ns		
		$T_J=125^{\circ}\text{C}$	230		ns		
		$T_J=150^{\circ}\text{C}$	280		ns		
E_{on}	Turn on Energy	$V_{CC}=600\text{V}, I_C=300\text{A}$ $R_G=2.7\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=125^{\circ}\text{C}$	42.1		mJ	
			$T_J=150^{\circ}\text{C}$	46.1		mJ	
E_{off}	Turn off Energy		$T_J=125^{\circ}\text{C}$	24.8		mJ	
			$T_J=150^{\circ}\text{C}$	27.4		mJ	
I_{SC}	Short Circuit Current		$tpsc \leq 10\mu\text{s}, V_{GE}=15\text{V}$ $T_J=150^{\circ}\text{C}, V_{CC}=800\text{V}$		1200		A
R_{thJC}	Junction to Case Thermal Resistance (Per IGBT)				0.105	K/W	

ELECTRICAL CHARACTERISTICS-Diode ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
V_F	Forward Voltage	$I_F=300\text{A}, V_{GE}=0\text{V}, T_J=25^{\circ}\text{C}$		1.7	2.1	V
		$I_F=300\text{A}, V_{GE}=0\text{V}, T_J=125^{\circ}\text{C}$		1.5		
		$I_F=300\text{A}, V_{GE}=0\text{V}, T_J=150^{\circ}\text{C}$		1.45		
t_{rr}	Reverse Recovery Time	$I_F=300\text{A}, V_R=600\text{V}$ $di_F/dt=-4000\text{A}/\mu\text{s}$ $T_J=150^{\circ}\text{C}$		540		ns
I_{RRM}	Max. Reverse Recovery Current			300		A
Q_{RR}	Reverse Recovery Charge			66.2		μC
E_{rec}	Reverse Recovery Energy			24.4		mJ
R_{thJCD}	Junction to Case Thermal Resistance (Per Diode)				0.18	K/W

MMG300D120UA6TC

MODULE CHARACTERISTICS ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions	Values	Unit	
T_{Jmax}	Max. Junction Temperature	175	°C	
T_{Jop}	Operating Temperature	-40~150		
T_{stg}	Storage Temperature	-40~125		
V_{isol}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), t=1minute	3000	V
CTI	Comparative Tracking Index		> 225	
Torque	to heatsink	Recommended (M6)	3~5	Nm
	to terminal	Recommended (M6)	2.5~5	Nm
Weight			300	g

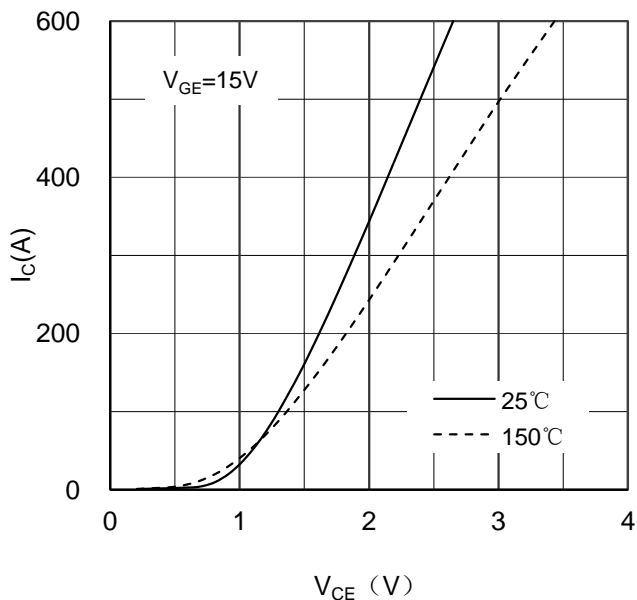


Figure 1. Typical Output Characteristics IGBT-inverter

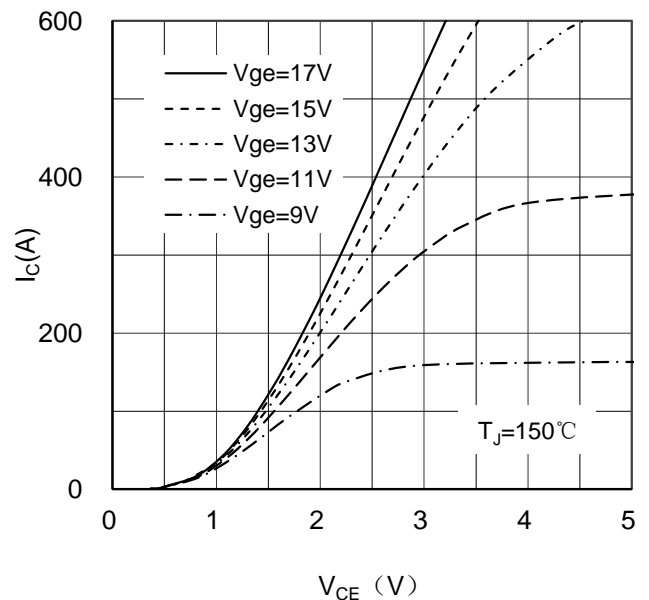


Figure 2. Typical Output Characteristics IGBT-inverter

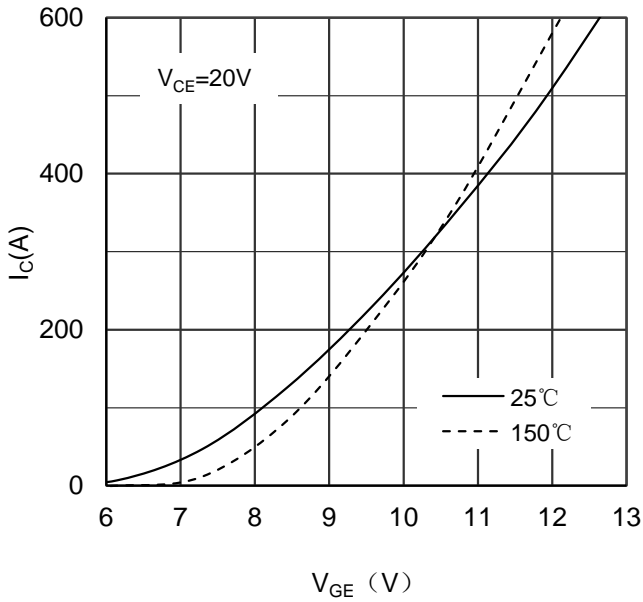


Figure 3. Typical Transfer characteristics IGBT-inverter

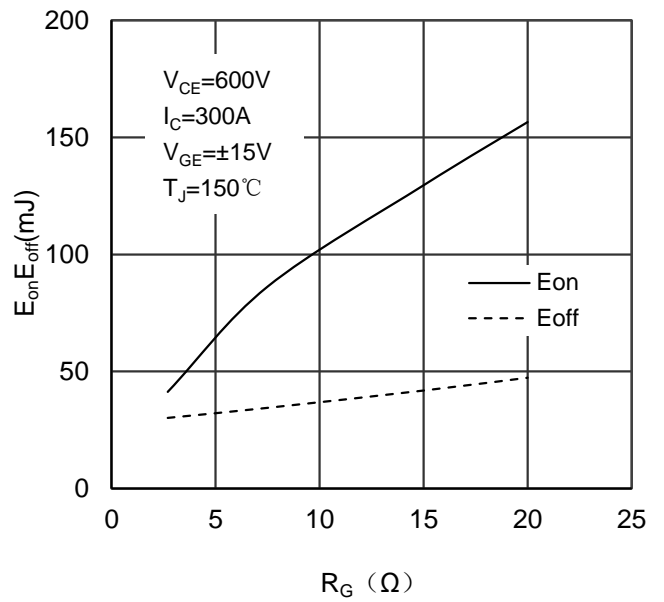


Figure 4. Switching Energy vs Gate Resistor IGBT-inverter

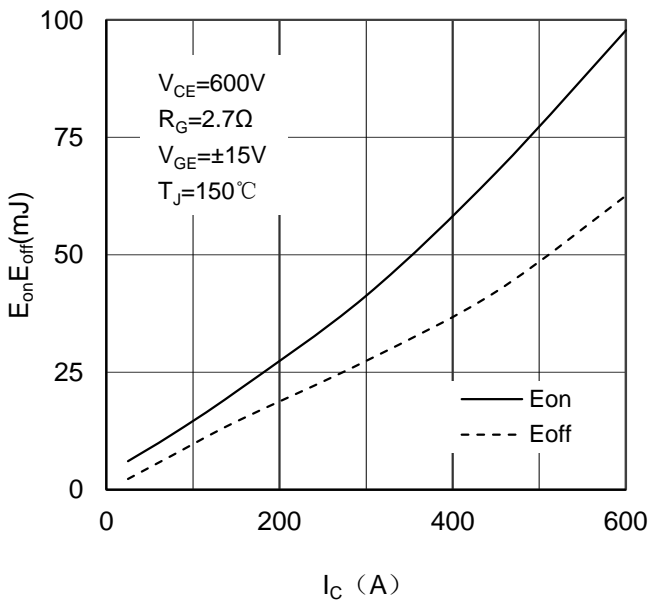


Figure 5. Switching Energy vs Collector Current IGBT-inverter

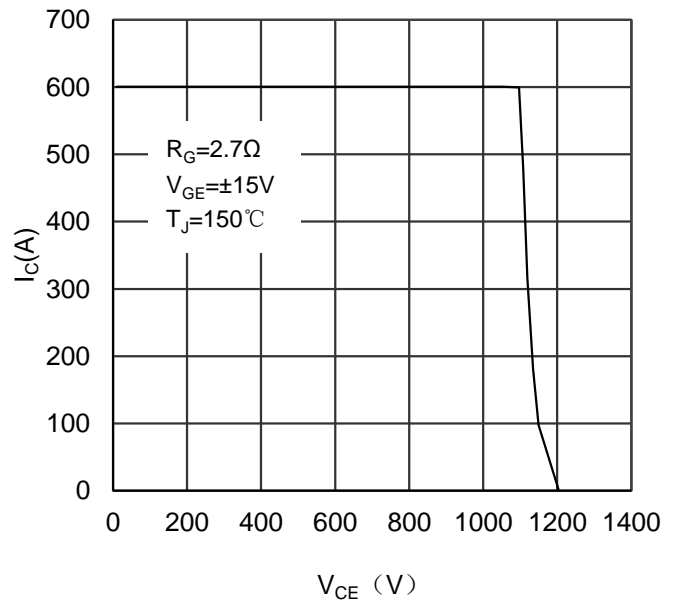


Figure 6. Reverse Biased Safe Operating Area IGBT-inverter

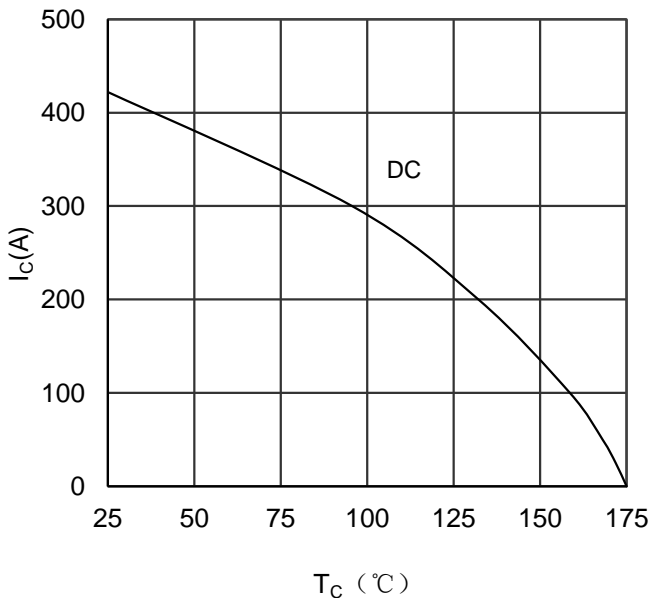


Figure 7. Collector Current vs Case temperature IGBT-inverter

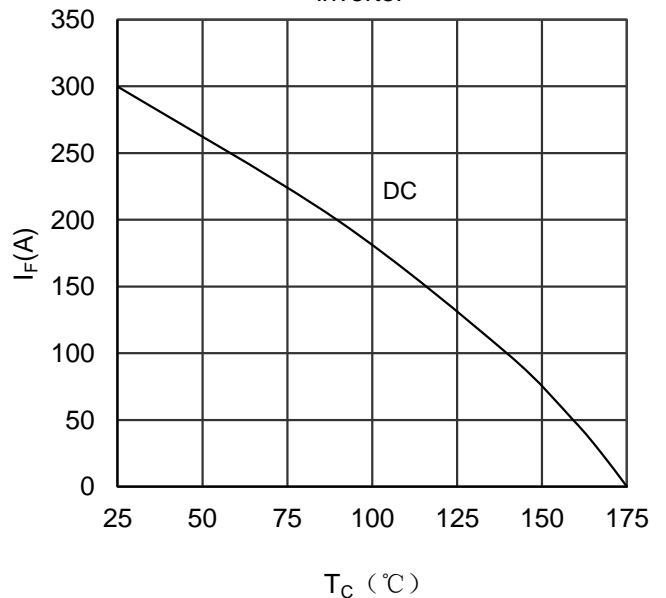


Figure 8. Forward current vs Case temperature Diode-inverter

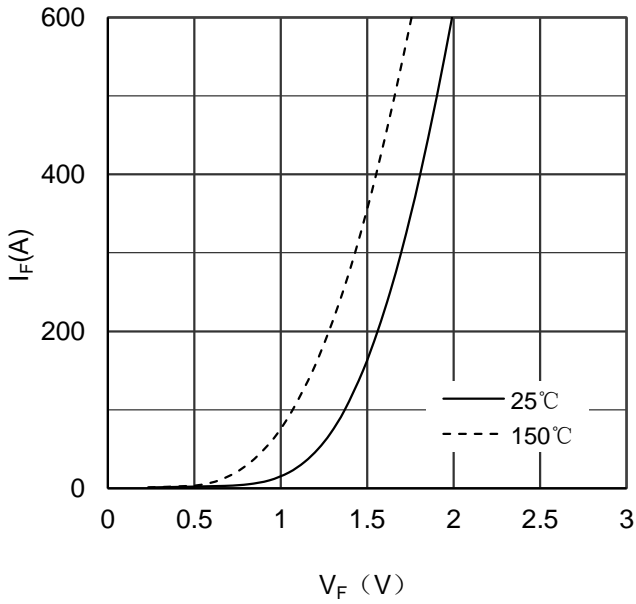


Figure 9. Diode Forward Characteristics Diode-inverter

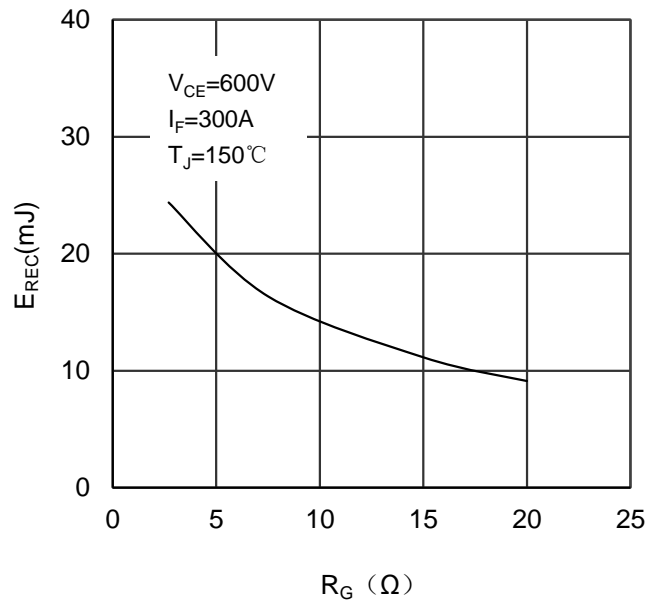


Figure 10. Switching Energy vs Gate Resistor Diode-inverter

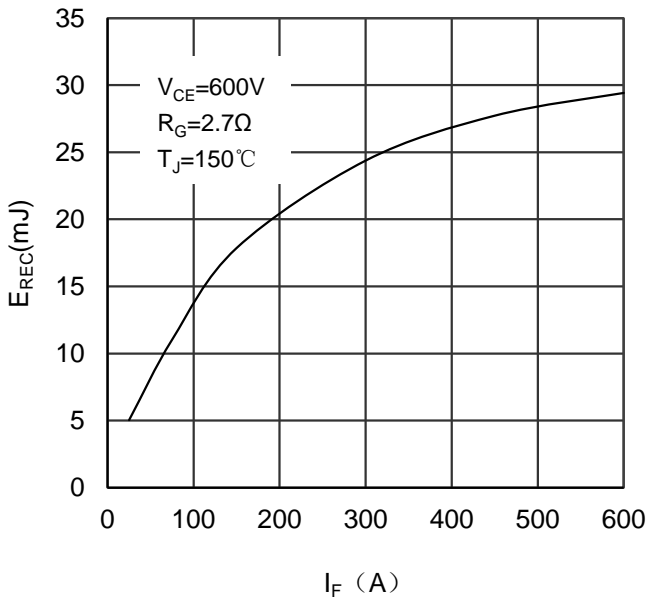


Figure 11. Switching Energy vs Forward Current Diode-inverter

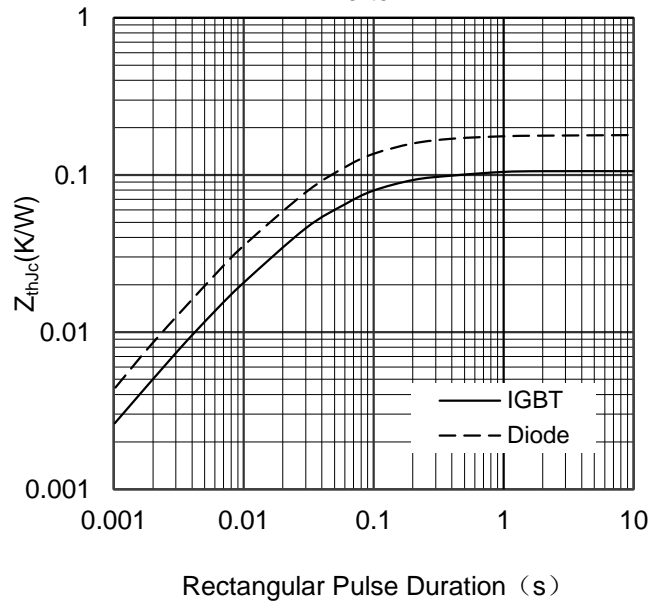


Figure 12. Transient Thermal Impedance of Diode and IGBT-inverter

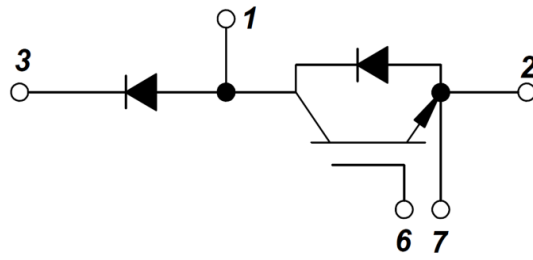
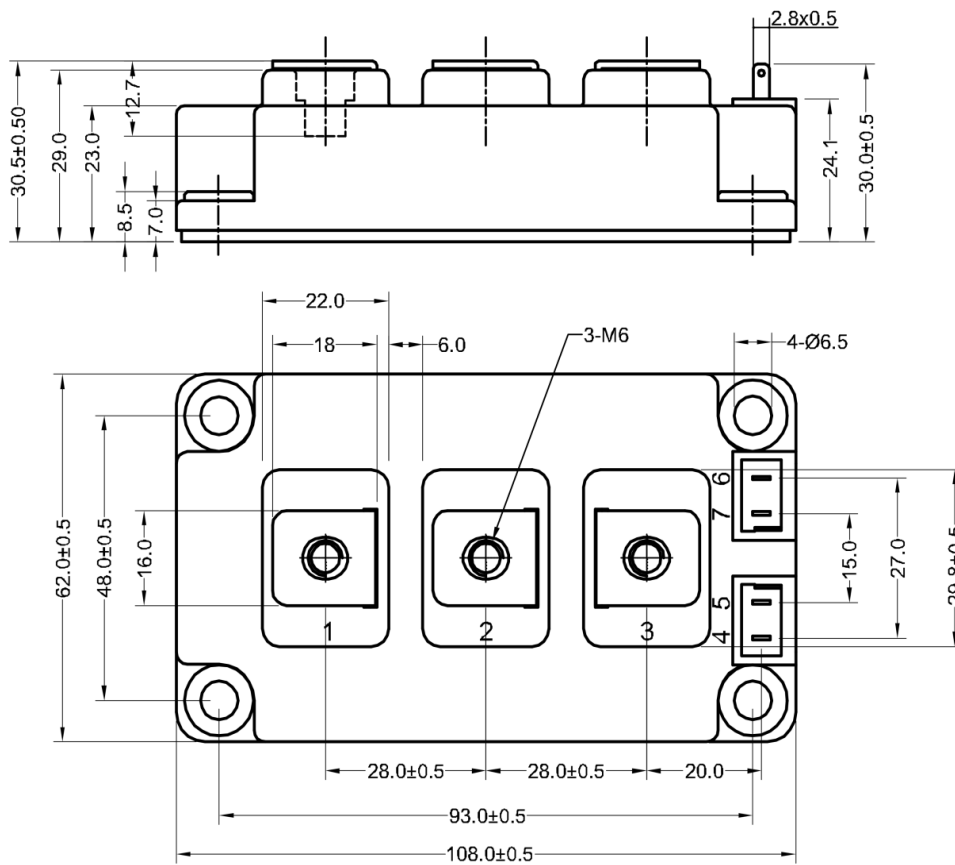


Figure 13. Circuit Diagram



Dimensions in (mm)
Figure 14. Package Outline